Complementary Power Transistors

DPAK For Surface Mount Applications

Designed for general purpose power and switching such as output or driver stages in applications such as switching regulators, converters, and power amplifiers.

Features

- Lead Formed for Surface Mount Application in Plastic Sleeves (No Suffix)
- Straight Lead Version in Plastic Sleeves ("-1" Suffix)
- Electrically Similar to Popular D44H/D45H Series
- Low Collector Emitter Saturation Voltage $V_{CE(sat)} = 1.0 \text{ Volt Max } @ 8.0 \text{ A}$
- Fast Switching Speeds
- Complementary Pairs Simplifies Designs
- Epoxy Meets UL 94 V-0 @ 0.125 in
- ESD Ratings: Human Body Model, 3B > 8000 V Machine Model, C > 400 V
- NJV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These are Pb-Free Packages*



ON Semiconductor®

http://onsemi.com

SILICON POWER TRANSISTORS 8 AMPERES 80 VOLTS, 20 WATTS

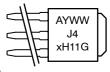
MARKING DIAGRAMS





DPAK CASE 369C STYLE 1





IPAK CASE 369D STYLE 1

A = Assembly Location

Y = Year WW = Work Week J4xH11 = Device Code x = 4 or 5

G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 7 of this data sheet.

^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

MAXIMUM RATINGS (T_A = 25°C, common for NPN and PNP, minus sign, "-", for PNP omitted, unless otherwise noted)

Rating	Symbol	Max	Unit
Collector–Emitter Voltage	V _{CEO}	80	Vdc
Emitter-Base Voltage	V _{EB}	5	Vdc
Collector Current – Continuous – Peak	Ic	8 16	Adc
Total Power Dissipation @ T _C = 25°C Derate above 25°C	P _D	20 0.16	W W/°C
Total Power Dissipation (Note 1) @ T _A = 25°C Derate above 25°C	P _D	1.75 0.014	W W/°C
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-55 to +150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{ heta JC}$	6.25	°C/W
Thermal Resistance, Junction-to-Ambient (Note 1)	$R_{\theta JA}$	71.4	°C/W
Lead Temperature for Soldering	T _L	260	°C

^{1.} These ratings are applicable when surface mounted on the minimum pad sizes recommended.

ELECTRICAL CHARACTERISTICS

 $(T_A = 25^{\circ}C, common for NPN and PNP, minus sign, "-", for PNP omitted, unless otherwise noted)$

Charac	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS			!		Į.	!
Collector–Emitter Sustaining Voltage ($I_C = 30 \text{ mA}, I_B = 0$)		V _{CEO(sus)}	80			Vdc
Collector Cutoff Current (V _{CE} = Rated V _{CEO} , V _{BE} = 0)		I _{CES}			1.0	μΑ
Emitter Cutoff Current (V _{EB} = 5 Vdc)		I _{EBO}			1.0	μΑ
ON CHARACTERISTICS						
Collector–Emitter Saturation Voltage ($I_C = 8$ Adc, $I_B = 0.4$ Adc)		V _{CE(sat)}			1	Vdc
Base-Emitter Saturation Voltage (I _C = 8 Adc, I _B = 0.8 Adc)		V _{BE(sat)}			1.5	Vdc
DC Current Gain (V _{CE} = 1 Vdc, I _C = 2 Adc)		h _{FE}	60			-
DC Current Gain (V _{CE} = 1 Vdc, I _C = 4 Adc)			40			
DYNAMIC CHARACTERISTICS			•	•	•	
Collector Capacitance (V _{CB} = 10 Vdc, f _{test} = 1 MHz)	MJD44H11, NJVMJD44H11G,/T4G/RLG MJD45H11, NJVMJD45H11T4G/RLG	C _{cb}		45 130		pF
Gain Bandwidth Product (I _C = 0.5 Adc, V _{CE} = 10 Vdc, f = 20 MHz)	MJD44H11, NJVMJD44H11G,/T4G/RLG MJD45H11, NJVMJD45H11T4G/RLG	f _T		85 90		MHz
SWITCHING TIMES			1		ļ	Į.
Delay and Rise Times (I _C = 5 Adc, I _{B1} = 0.5 Adc)	MJD44H11, NJVMJD44H11G,/T4G/RLG MJD45H11, NJVMJD45H11T4G/RLG	$t_d + t_r$		300 135		ns
Storage Time (I _C = 5 Adc, I _{B1} = I _{B2} = 0.5 Adc)	MJD44H11, NJVMJD44H11G,/T4G/RLG MJD45H11, NJVMJD45H11T4G/RLG	t _s		500 500		ns
Fall Time ($I_C = 5$ Adc, $I_{B1} = I_{B2} = 0.5$ Adc	MJD44H11, NJVMJD44H11G,/T4G/RLG MJD45H11, NJVMJD45H11T4G/RLG	t _f		140 100		ns

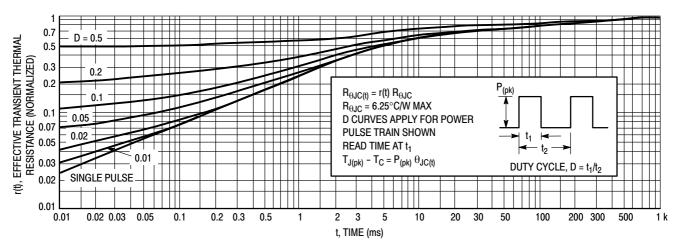


Figure 1. Thermal Response

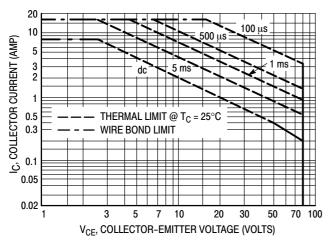


Figure 2. Maximum Forward Bias Safe Operating Area

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I_C – V_{CE} limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 2 is based on $T_{J(pk)} = 150^{\circ}\text{C}$; T_{C} is variable depending on conditions. Second breakdown pulse limits are valid for duty cycles to 10% provided $T_{J(pk)} \leq 150^{\circ}\text{C}$. $T_{J(pk)}$ may be calculated from the data in Figure 1. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

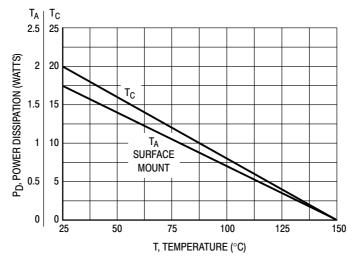


Figure 3. Power Derating

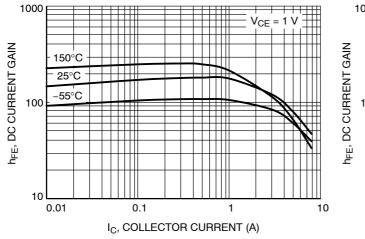


Figure 4. MJD44H11 DC Current Gain

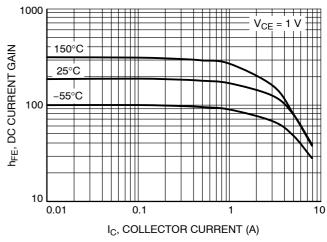


Figure 5. MJD45H11 DC Current Gain

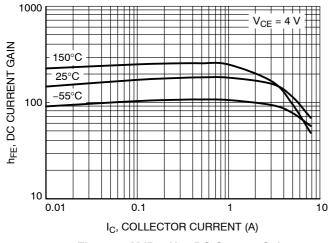


Figure 6. MJD44H11 DC Current Gain

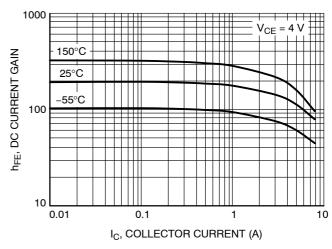


Figure 7. MJD45H11 DC Current Gain

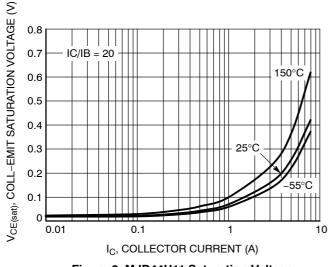


Figure 8. MJD44H11 Saturation Voltage $V_{\text{CE(sat)}}$

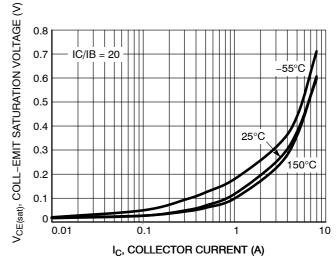
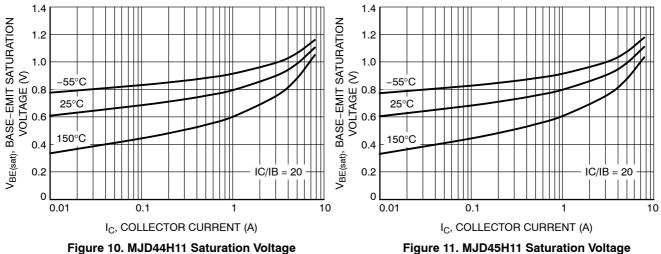
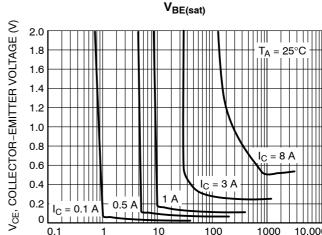


Figure 9. MJD45H11 Saturation Voltage $V_{\text{CE(sat)}}$



0.1

Figure 10. MJD44H11 Saturation Voltage V_{BE(sat)}



V_{CE}, COLLECTOR-EMITTER VOLTAGE (V) 2.0 1.8 1.6 1.4 1.2 1.0 0.8 0.6 $I_C = 3 A$ 0.2 $I_{C} = 0.1 \text{ A}$ 0.5 A 0.1 1000 10,000 IB, BASE CURRENT (mA)

Figure 12. MJD44H11 Collector Saturation Region

Figure 13. MJD45H11 Collector Saturation Region

IB, BASE CURRENT (mA)

100

1000

10,000

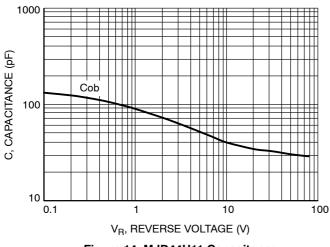


Figure 14. MJD44H11 Capacitance

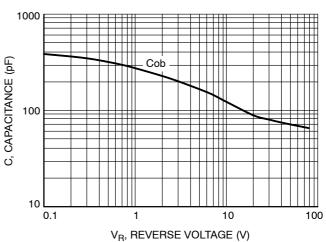


Figure 15. MJD45H11 Capacitance

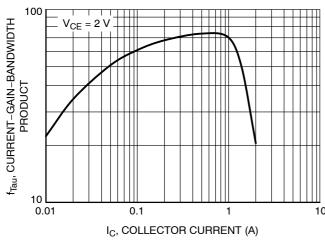


Figure 16. MJD44H11 **Current-Gain-Bandwidth Product**

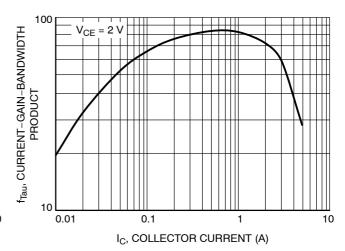


Figure 17. MJD45H11 **Current-Gain-Bandwidth Product**

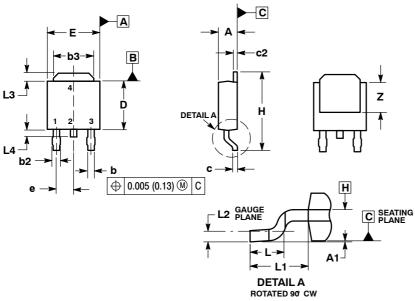
ORDERING INFORMATION

Device	Package Type	Package	Shipping [†]	
MJD44H11G	DPAK (Pb-Free)	2222		
NJVMJD44H11G	DPAK (Pb-Free)	369C	75 Units / Rail	
MJD44H11-1G	DPAK-3 (Pb-Free)	369D		
MJD44H11RLG	DPAK (Pb-Free)		1 000 /T 0 D 1	
NJVMJD44H11RLG	DPAK (Pb-Free)		1,800 / Tape & Reel	
MJD44H11T4G	DPAK (Pb-Free)			
NJVMJD44H11T4G	DPAK (Pb-Free)	369C	2,500 / Tape & Reel	
MJD44H11T5G	DPAK (Pb-Free)			
MJD45H11G	DPAK (Pb-Free)			
MJD45H11-1G	DPAK-3 (Pb-Free)	369D	75 Units / Rail	
MJD45H11RLG	DPAK (Pb-Free)			
NJVMJD45H11RLG	DPAK (Pb-Free)	369C	1,800 / Tape & Reel	
MJD45H11T4G	DPAK (Pb-Free)	3090	2 500 / Topo 9 Deel	
NJVMJD45H11T4G	DPAK (Pb-Free)		2,500 / Tape & Reel	

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DPAK CASE 369C ISSUE D



- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

 2. CONTROLLING DIMENSION: INCHES.

 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.

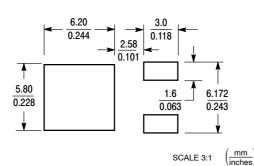
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED a 006 INCHES PER SIDE
- NOT EXCEED 0.006 INCHES PER SIDE.

 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

 6. DATUMS A AND B ARE DETERMINED AT DATUM

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090 BSC		2.29 BSC		
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108 REF		2.74 REF		
L2	0.020 BSC		0.51 BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0 155		3.93		

SOLDERING FOOTPRINT*



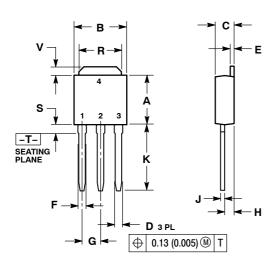
*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

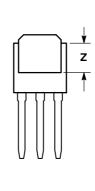
STYLE 1: PIN 1. BASE

- 2. COLLECTOR 3. EMITTER
- 4. COLLECTOR

PACKAGE DIMENSIONS

IPAK CASE 369D **ISSUE C**





NOTES

- DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090 BSC		2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

PIN 1. BASE 2. COLLI

COLLECTOR

EMITTER COLLECTOR

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